

-40A, -20V P-CHANNEL MOSFET

GENERAL DESCRIPTION

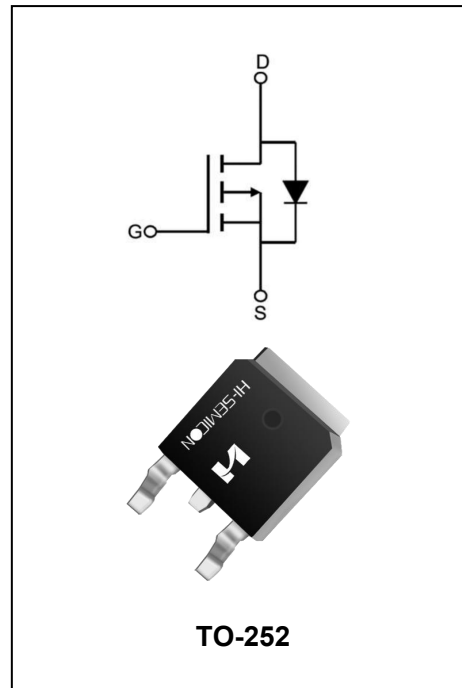
The SFD4002PT uses advanced trench technology and design to provide excellent $R_{DS(on)}$ with low gate charge. It can be used in a wide variety of applications.

Features

- ◆ N-CHANNEL
- ◆ $V_{DS}=-40V, I_D=-20A$
- ◆ $R_{DS(on)(TYP)}=23m\ \Omega ; (V_{GS}=-10V, I_D=-15A)$
- ◆ $R_{DS(on)(TYP)}=29m\ \Omega ; (V_{GS}=-4.5V, I_D=-8A)$

Application

- ◆ Load switch
- ◆ PWM application



ORDERING INFORMATION

Part No.	Package	Marking	Material	Packing
SFD4002PT	TO-252-2L	SFD4002PT	Pb Free	Reel

ABSOLUTE MAXIMUM RATINGS (T_J=25°C unless otherwise noted)

Characteristics		Symbol	Ratings	Unit
Drain-Source Voltage		V _{DS}	-40	V
Gate-Source Voltage		V _{GS}	±20	
Drain Current	T _C = 25°C	I _D	-20	A
	T _C = 100°C		-14	
Drain Current Pulsed(Note 1)		I _{DM}	-80	
Power Dissipation(T _C =25°C)		P _D	50	W
Avalanche energy(Note 4)		E _{AS}	81	mJ
Operation Junction Temperature Range		T _J	-55~+150	°C
Storage Temperature Range		T _{stg}	-55~+150	
Maximum lead temperature for soldering purposes, 1/8" from case for 5 seconds		TL	300	

THERMAL CHARACTERISTICS

Characteristics	Symbol	MAX	Unit
Thermal Resistance, Junction-to-Case	R _{θJC}	2.5	°C/W
Thermal Resistance, Junction-to-Ambient	R _{θJA}	62	

ELECTRICAL CHARACTERISTICS

Characteristics	Symbol	Test conditions	Min.	Typ.	Max.	Unit
Off Characteristics						
Drain -Source Breakdown Voltage	B _{VDS}	V _{GS} =0V, I _D =-250μA	-40	--	--	V
Drain-Source Leakage Current	I _{DSS}	V _{DS} =-40V, V _{GS} =0V	--	--	1	uA
Gate-Source Leakage Current	I _{GSS}	V _{GS} =20V, V _{DS} =0V	--	--	100	nA
Gate-Source Leakage Current	I _{GSS}	V _{GS} =-20V, V _{DS} =0V	--	--	-100	
On Characteristics						
Gate Threshold Voltage	V _{GS(th)}	V _{GS} =V _{DS} , I _D =-250μA	-1.0	-1.5	-2.0	V
Static Drain- Source On State Resistance	R _{DS(on)}	V _{GS} =-10V, I _D =-15A	--	23	27	mΩ
		V _{GS} =-4.5V, I _D =-8A	--	29	36	
Dynamic Characteristics						
Input Capacitance	C _{iss}	V _{DS} =-20V V _{GS} =0V f=1.0MHZ	--	1382	--	pF
Output Capacitance	C _{oss}		--	91	--	
Reverse Transfer Capacitance	C _{rss}		--	88	--	
Switching Characteristics						
Turn-on Delay Time	t _{d(on)}	V _{DD} =-20V, V _{GS} =-10V R _G =6.0Ω, I _D =-10A (Note 1.2)	--	8.1	--	nS
Turn-on Rise Time	t _r		--	3.7	--	
Turn-off Delay Time	t _{d(off)}		--	31.8	--	
Turn-off Fall Time	t _f		--	7.2	--	

Total Gate Charge	Q_g	$V_{DS}=-20V, I_D=-10A$ $V_{GS}=-10V$ (Note 1.2)	--	25.5	--	nC
Gate-Source Charge	Q_{gs}		--	3.2	--	
Gate-Drain Charge	Q_{gd}		--	6.9	--	

SOURCE-DRAIN DIODE RATINGS AND CHARACTERISTICS

Characteristics	Symbol	Test conditions	Min.	Typ.	Max.	Unit
Continuous Source Current	I_S	Integral Reverse P-N Junction Diode in the MOSFET	--	--	-20	A
Pulsed Source Current	I_{SM}		--	--	-80	
Diode Forward Voltage	V_{SD}	$I_S = -20A, V_{GS} = 0V$	--	--	-1.2	V
Body Diode Reverse Recovery Time	t_{rr}	$I_F = -20A,$ $di/dt = 100A/\mu S$	--	28	--	ns
Body Diode Reverse Recovery Charge	Q_{rr}		--	35	--	uc

NOTE:

1. Pulse width limited by maximum junction temperature
2. Pulse Test: Pulse width $\leq 300\mu s$, Duty cycle $\leq 2\%$
3. Essentially independent of operating temperature
4. E_{AS} condition: $T_J = 25^\circ C, V_{DD} = -20V, V_G = -10V, R_g = 25, L = 0.5mH$.

Typical Performance Characteristics

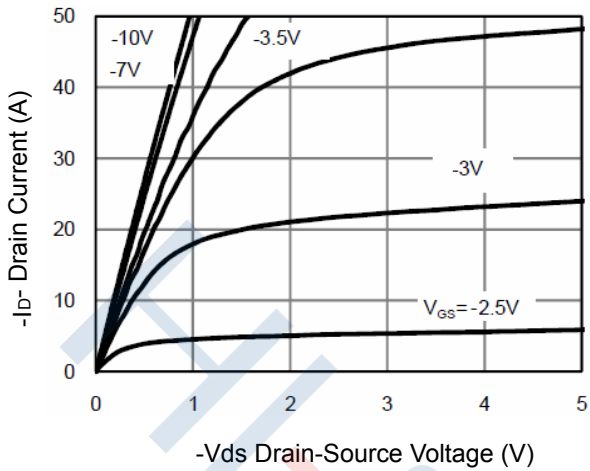


Figure 1 Output Characteristics

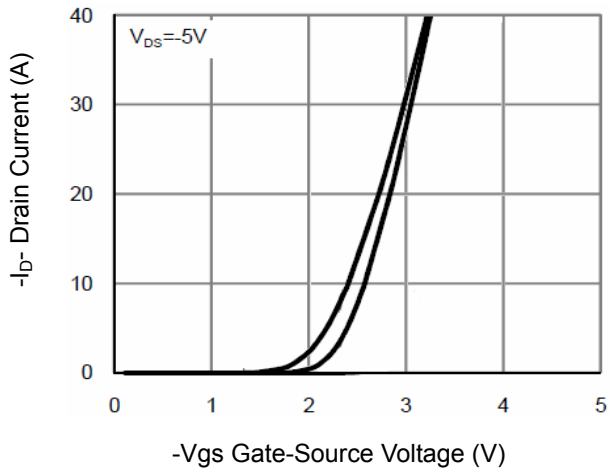


Figure 2 Transfer Characteristics

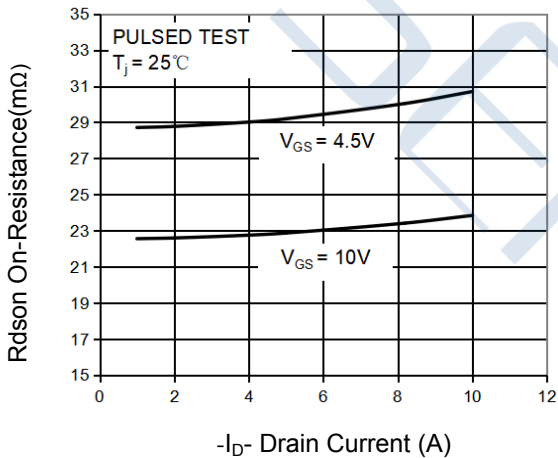


Figure 3 Rdson- Drain Current

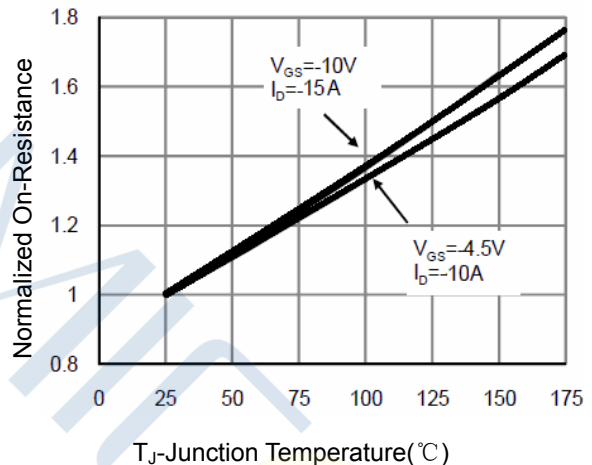


Figure 4 Rdson-Junction Temperature

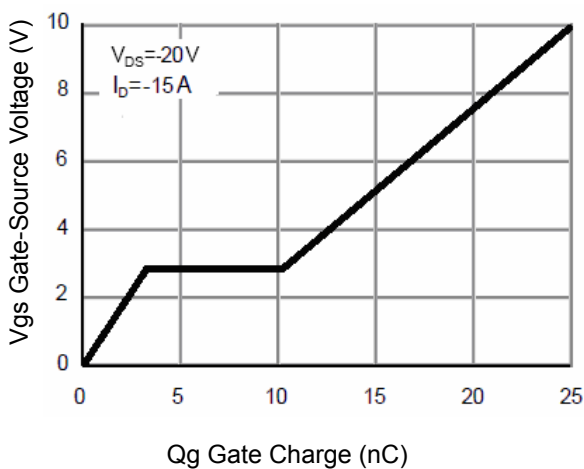


Figure 5 Gate Charge

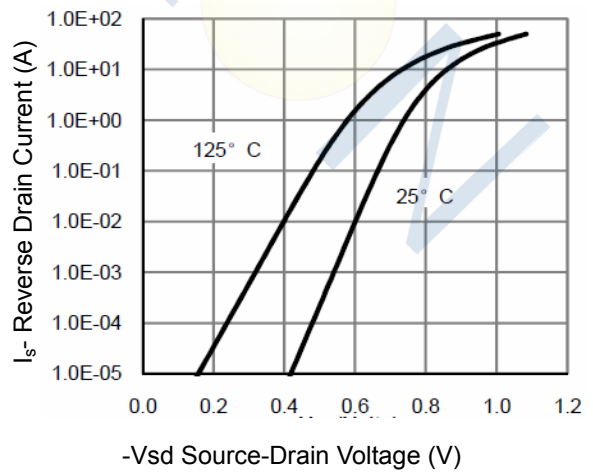


Figure 6 Source- Drain Diode Forward

Typical Performance Characteristics

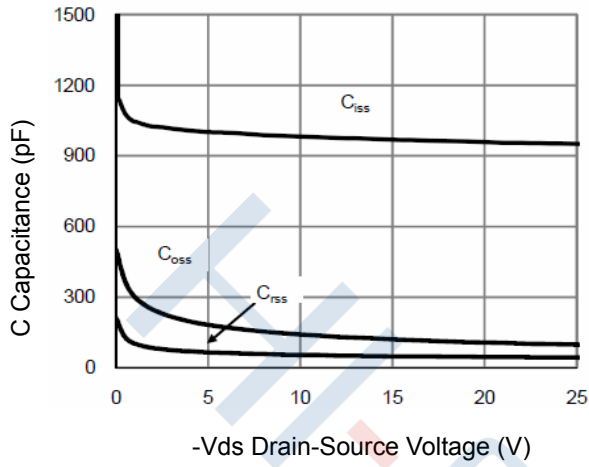


Figure 7 Capacitance vs Vds

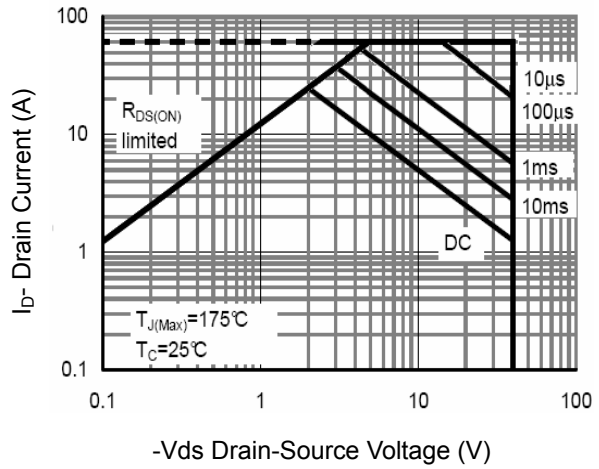
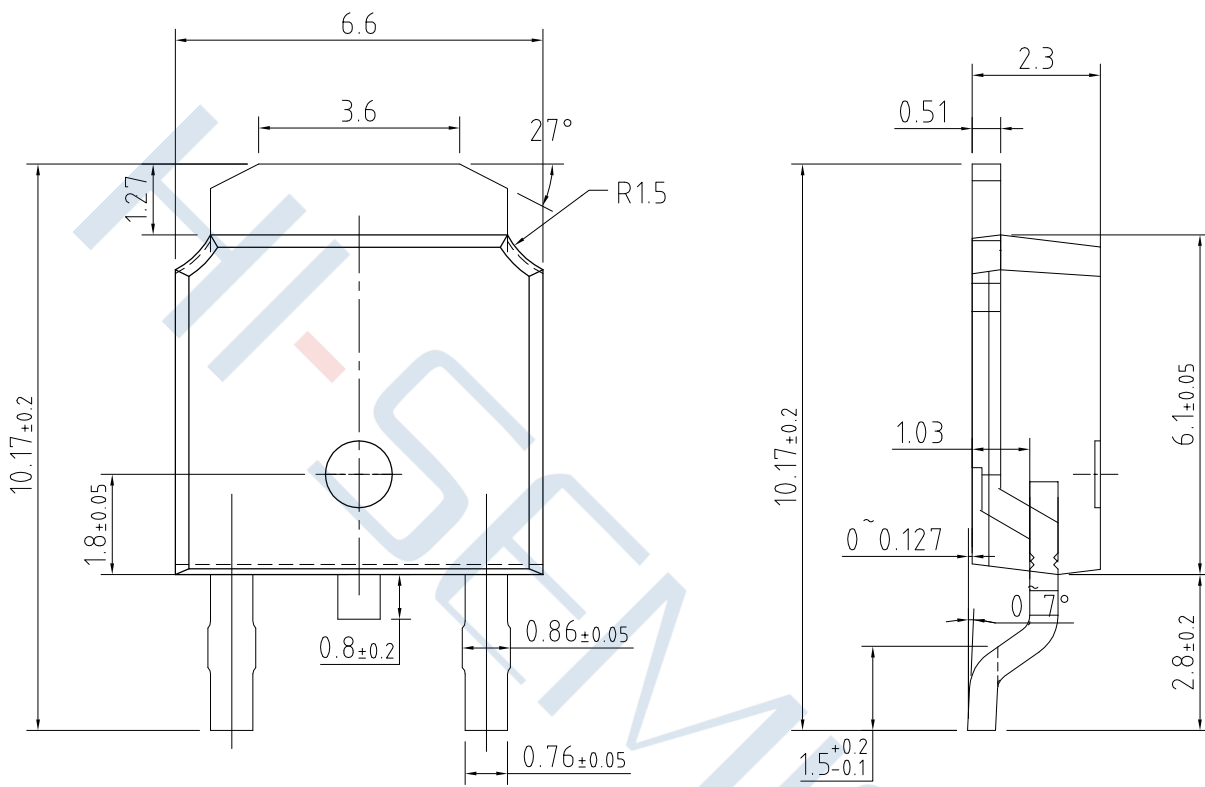


Figure 8 Safe Operation Area

Package Dimensions of SOT-23-3L



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